

Special NSREC 2023 Issue of the IEEE TRANSACTIONS ON NUCLEAR SCIENCE Editor Comments

THE April 2024 Special Issue of the IEEE TRANSACTIONS ON NUCLEAR SCIENCE (TNS) contains selected papers from the 60th annual IEEE International Nuclear and Space Radiation Effects Conference (NSREC), which was held in Kansas City, MO, USA, from July 24 to 28, 2023. The IEEE NSREC is sponsored by the IEEE Nuclear and Plasma Sciences Society. More than 55 of the papers presented during NSREC are included in this year's special issue. This issue is not a conference proceeding or a conference record. Papers that appear in this issue have all successfully completed the regular journal review process before the special issue deadline. A few other papers presented during the conference may appear in the subsequent issues of IEEE TNS.

The IEEE TNS is the premier archival journal for research on space and nuclear radiation effects in materials, devices, circuits, and systems. This is the result of conscientious efforts of the authors, who present and document their work, and the reviewers, who selflessly volunteer their time and talent to help review the manuscripts. Each paper in this journal has been reviewed by 2–4 experts selected by the editors for their expertise and knowledge of the subject areas and has been revised substantially in response to reviews. All papers benefit greatly from this peer review process. The reviewers listed on the following pages contributed vitally to this process. We would like to express our sincere appreciation to each of them for accepting this difficult, but critical role in the process.

To provide consistent reviews of papers, IEEE TNS relies on a year-round editorial board that arranges reviews for submissions throughout the year in the area of radiation effects. The review process is managed by a senior editor and nine associate editors who are technically knowledgeable in one or more specializations and are experienced in the publication process. Their names are listed as follows.

We thank William Robinson for his past service as an associate editor and are pleased to welcome Janet Barth as an associate editor this year.

Zane Bell's contributions as the Editor-in-Chief of IEEE TNS are essential to the editorial process as well. We also thank Rebecca Hytowitz and Peter Stavenick of the IEEE Publications staff for their support in making this process run smoothly.

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